Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,142	BANERJEE ET AL.	
Examiner	Art Unit	
John Rivell	3753	

SEARCHED					
Class	Subclass	Date	Examiner		
137	587 588 808 812	1/24/2006	R		
123	516	1/24/2006	W)		
141	59 286 290	1/24/2006	12		
220	86.2	1/24/2006	12h		
All	Updated	7/20/2000			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
-					
-	. L				
1			•		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
None		1/24/2006	R	
		· · · · · · · · · · · · · · · · · · ·		